Power MOSFET

30 V, 88 A, Single N-Channel, DPAK/IPAK

Features

- Low R_{DS(on)} to Minimize Conduction Losses
- Low Capacitance to Minimize Driver Losses
- Optimized Gate Charge to Minimize Switching Losses
- These are Pb-Free Devices

Applications

- CPU Power Delivery
- DC-DC Converters
- Low Side Switching

MAXIMUM RATINGS (T_J = 25°C unless otherwise noted)

Param	Parameter				
Drain-to-Source Voltag	V _{DSS}	30	V		
Gate-to-Source Voltage	е		V _{GS}	±20	V
Continuous Drain		T _A = 25°C	I _D	16	Α
Current (R _{θJA}) (Note 1)		T _A = 85°C		12.6	
Power Dissipation (R _{θJA}) (Note 1)		T _A = 25°C	P _D	2.24	W
Continuous Drain		T _A = 25°C	I _D	12.6	Α
Current (R _{θJA}) (Note 2)	Steady	T _A = 85°C		9.8	
Power Dissipation (R _{θJA}) (Note 2)	State	T _A = 25°C	P _D	1.35	W
Continuous Drain		T _C = 25°C	I _D	88	Α
Current (R _{θJC}) (Note 1)		T _C = 85°C		68	
Power Dissipation $(R_{\theta JC})$ (Note 1)		T _C = 25°C	P _D	66	W
Pulsed Drain Current	t _p =10μs	T _A = 25°C	I _{DM}	175	Α
Current Limited by Packa	age	T _A = 25°C	I _{DmaxPkg}	45	Α
Operating Junction and S	Storage Te	emperature	T _J , T _{stg}	-55 to 175	°C
Source Current (Body Di	ode)		I _S	55	Α
Source Current (Body Di	I _{SM}	175	Α		
Drain to Source dV/dt			dV/dt	6.0	V/ns
Single Pulse Drain-to-Source Avalanche Energy (V_{DD} = 24 V, V_{GS} = 10 V, L = 1.0 mH, $I_{L(pk)}$ = 24 A, R_G = 25 Ω)			E _{AS}	288	mJ
Lead Temperature for So (1/8" from case for 10 s)	Idering Pu	rposes	TL	260	°C

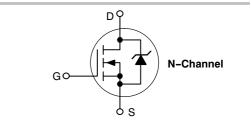
Stresses exceeding Maximum Ratings may damage the device. Maximum Ratings are stress ratings only. Functional operation above the Recommended Operating Conditions is not implied. Extended exposure to stresses above the Recommended Operating Conditions may affect device reliability.



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V _{(BR)DSS}	R _{DS(on)} MAX	I _D MAX
30 V	5.0 mΩ @ 10 V	88 A
30 V	7.4 mΩ @ 4.5 V	00 /







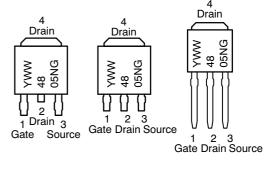


CASE 369AA DPAK (Bent Lead) STYLE 2

CASE 369AC 3 IPAK (Straight Lead)

CASE 369D IPAK (Straight Lead DPAK)

MARKING DIAGRAMS & PIN ASSIGNMENTS



Y = Year WW = Work Week 4805N = Device Code G = Pb-Free Package

ORDERING INFORMATION

See detailed ordering and shipping information in the package dimensions section on page 6 of this data sheet.

THERMAL RESISTANCE MAXIMUM RATINGS

Parameter	Symbol	Value	Unit
Junction-to-Case (Drain)	$R_{ heta JC}$	2.25	°C/W
Junction-to-TAB (Drain)	$R_{\theta JC-TAB}$	3.5	
Junction-to-Ambient - Steady State (Note 1)	$R_{ heta JA}$	67	
Junction-to-Ambient - Steady State (Note 2)	$R_{ heta JA}$	111	

- Surface-mounted on FR4 board using 1 in sq pad size, 1 oz Cu.
 Surface-mounted on FR4 board using the minimum recommended pad size.

FLECTRICAL CHARACTERISTICS (T. - 25°C unless otherwise noted)

Parameter	Symbol	Test Co	ndition	Min	Тур	Max	Unit
OFF CHARACTERISTICS					•	•	
Drain-to-Source Breakdown Voltage	V _{(BR)DSS}	$V_{GS} = 0 \text{ V}, I_D = 250 \mu\text{A}$		30			V
Drain-to-Source Breakdown Voltage Temperature Coefficient	V _{(BR)DSS} /T _J				27		mV/°C
Zero Gate Voltage Drain Current	I _{DSS}	V _{GS} = 0 V, V _{DS} = 24 V	T _J = 25°C T _{-I} = 125°C			1.0	μΑ
Gate-to-Source Leakage Current	I _{GSS}	V _{DS} = 0 V, V	_{GS} = ±20 V			±100	nA
ON CHARACTERISTICS (Note 3)							1
Gate Threshold Voltage	V _{GS(TH)}	$V_{GS} = V_{DS}$	I _D = 250 μA	1.5		2.5	V
Negative Threshold Temperature Coefficient	V _{GS(TH)} /T _J				5.86		mV/°C
Drain-to-Source On Resistance	R _{DS(on)}	V _{GS} = 10 to	I _D = 30 A		4.3	5.0	mΩ
		11.5 V	I _D = 15 A		4.2		1
		V _{GS} = 4.5 V	I _D = 30 A		6.0	7.4	1
			I _D = 15 A		5.8		1
Forward Transconductance	gFS	V _{DS} = 15 V	, I _D = 15 A		17		S
CHARGES AND CAPACITANCES					•	•	•
Input Capacitance	C _{iss}				2865		pF
Output Capacitance	C _{oss}	$V_{GS} = 0 \text{ V, f} = 1.0 \text{ MHz,}$ $V_{DS} = 12 \text{ V}$			610		1
Reverse Transfer Capacitance	C _{rss}	• 03 -			338		1
Total Gate Charge	Q _{G(TOT)}				20.5	26	nC
Threshold Gate Charge	Q _{G(TH)}	V _{GS} = 4.5 V,	V _{DS} = 15 V,		4.05		
Gate-to-Source Charge	Q_{GS}	I _D = 3			8.28		1
Gate-to-Drain Charge	Q_{GD}				8.36		
Total Gate Charge	Q _{G(TOT)}	V _{GS} = 11.5 V _D			48		nC
SWITCHING CHARACTERISTICS (Note 4)							
Turn-On Delay Time	t _{d(on)}				17.2		ns
Rise Time	t _r	$V_{GS} = 4.5 \text{ V}, V_{DS} = 15 \text{ V},$ $I_D = 15 \text{ A}, R_G = 3.0 \Omega$			20.3		
Turn-Off Delay Time	t _{d(off)}				20.8		
Fall Time	t _f				8.0		
Turn-On Delay Time	t _{d(on)}				10.8		ns
Rise Time	t _r	V _{GS} = 11.5 V, V _{DS} = 15 V,			20.5		1
Turn-Off Delay Time	t _{d(off)}	I _D = 15 A, I			30.8		
Fall Time	t _f				4.4		1

- Pulse Test: Pulse Width ≤ 300 μs, Duty Cycle ≤ 2%.
 Switching characteristics are independent of operating junction temperatures.

ELECTRICAL CHARACTERISTICS ($T_J = 25^{\circ}C$ unless otherwise noted)

Parameter	Symbol	Test Condition		Min	Тур	Max	Unit
DRAIN-SOURCE DIODE CHARACTERISTICS							
Forward Diode Voltage	V _{SD}	V _{GS} = 0 V,	T _J = 25°C		0.87	1.2	V
		I _S = 30 A	T _J = 125°C		0.76		
Reverse Recovery Time	t _{RR}				25.7		ns
Charge Time	ta	$V_{GS} = 0 \text{ V, dls/}$	V _{GS} = 0 V, dls/dt = 100 A/μs,		13.1		
Discharge Time	tb	I _S = 30 A			12.6		
Reverse Recovery Time	Q _{RR}				18		nC
PACKAGE PARASITIC VALUES							
Source Inductance	L _S				2.49		nH
Drain Inductance, DPAK	L _D				0.0164		
Drain Inductance, IPAK	L _D	T _A = 25°C			1.88		1
Gate Inductance	L _G				3.46		1
Gate Resistance	R _G				0.8		Ω

TYPICAL PERFORMANCE CURVES

180

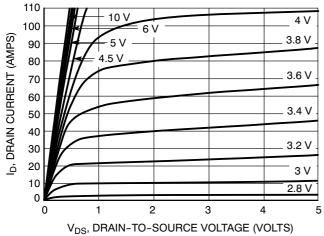
160

140

120

100

 $V_{DS} \ge 10 \text{ V}$



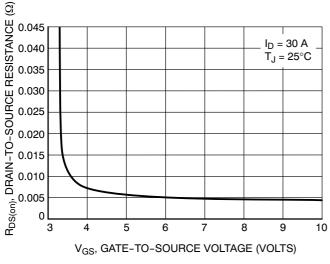
DRAIN CURRENT (AMPS) 80 60 T_J = 125°C 40 $T_J = 25^{\circ}C$ ڡٛ $T_J = -55^{\circ}C$ 0 0 2 3 4

Figure 1. On-Region Characteristics

V_{GS}, GATE-TO-SOURCE VOLTAGE (VOLTS) Figure 2. Transfer Characteristics

5

6



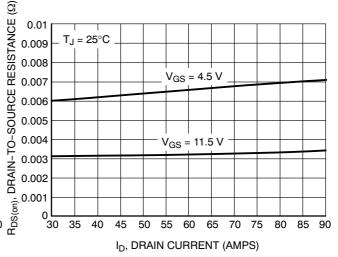
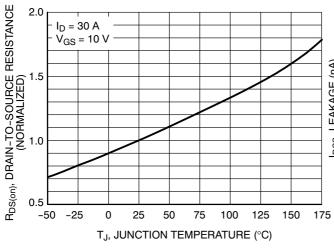


Figure 3. On-Resistance vs. Gate-to-Source Voltage

Figure 4. On-Resistance vs. Drain Current and **Gate Voltage**



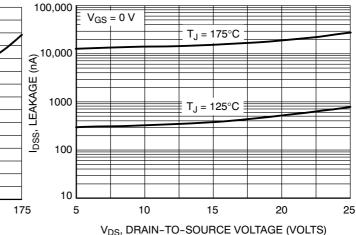
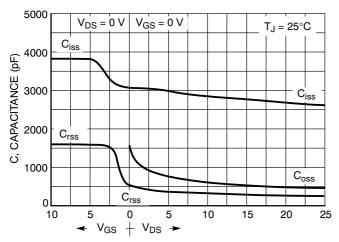


Figure 5. On-Resistance Variation with **Temperature**

Figure 6. Drain-to-Source Leakage Current vs. Drain Voltage

TYPICAL PERFORMANCE CURVES



GATE-TO-SOURCE OR DRAIN-TO-SOURCE VOLTAGE (VOLTS)

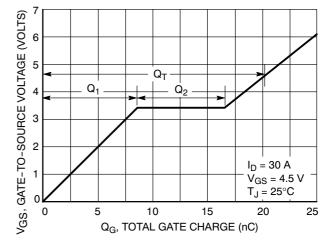


Figure 8. Gate-To-Source and Drain-To-Source Voltage vs. Total Charge



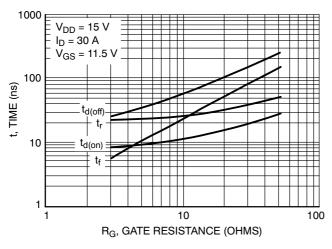


Figure 9. Resistive Switching Time Variation vs. Gate Resistance

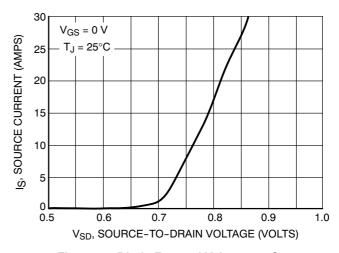
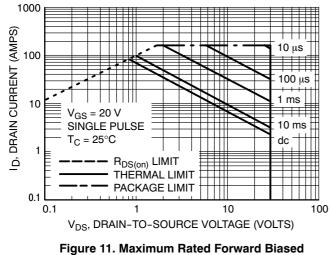


Figure 10. Diode Forward Voltage vs. Current



Safe Operating Area

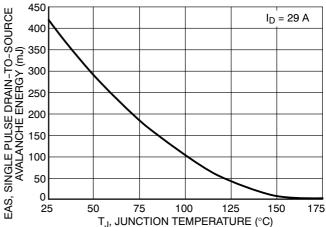


Figure 12. Maximum Avalanche Energy vs. Starting Junction Temperature

TYPICAL PERFORMANCE CURVES

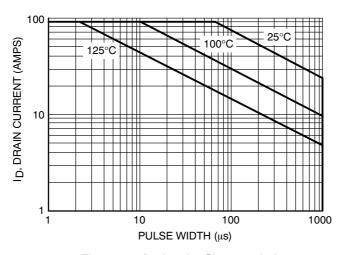


Figure 13. Avalanche Characteristics

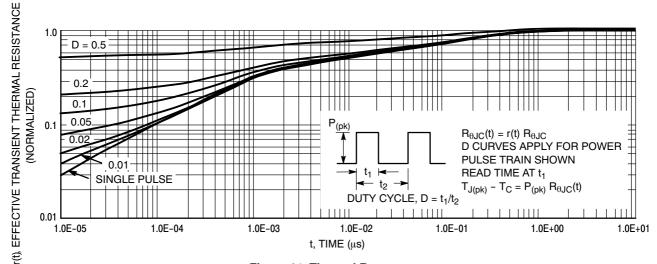


Figure 14. Thermal Response

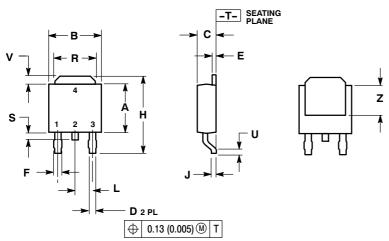
ORDERING INFORMATION

Order Number	Package	Shipping [†]
NTD4805NT4G	DPAK (Pb-Free)	2500 Tape & Reel
NTD4805N-1G	IPAK (Pb-Free)	75 Units/Rail
NTD4805N-35G	IPAK Trimmed Lead (3.5 \pm 0.15 mm) (Pb-Free)	75 Units/Rail

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.

PACKAGE DIMENSIONS

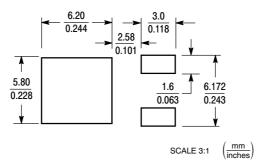
DPAK CASE 369AA-01 ISSUE A



- NOTES: 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982. 2. CONTROLLING DIMENSION: INCH.

	INC	HES	MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.025	0.035	0.63	0.89
E	0.018	0.024	0.46	0.61
F	0.030	0.045	0.77	1.14
Н	0.386	0.410	9.80	10.40
J	0.018	0.023	0.46	0.58
L	0.090 BSC		2.29	BSC
R	0.180	0.215	4.57	5.45
S	0.024	0.040	0.60	1.01
U	0.020		0.51	
V	0.035	0.050	0.89	1.27
Z	0.155		3.93	

SOLDERING FOOTPRINT*

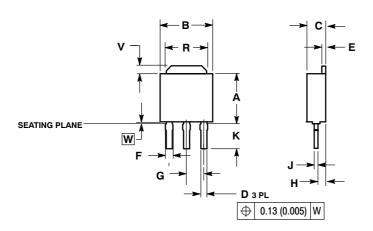


^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

PACKAGE DIMENSIONS

3 IPAK, STRAIGHT LEAD

CASE 369AC-01 ISSUE O



NOTES:

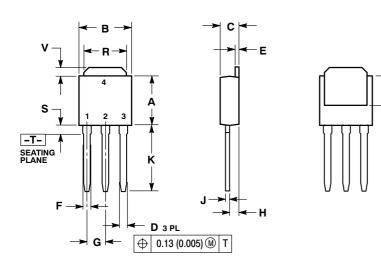
- DIMENSIONING AND TOLERANCING
 PER ANSI Y14.5M, 1982.
- CONTROLLING DIMENSION: INCH. SEATING PLANE IS ON TOP OF
- DAMBAR POSITION.
 DIMENSION A DOES NOT INCLUDE DAMBAR POSITION OR MOLD GATE.

	INC	HES	MILLIM	ETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.22
В	0.250	0.265	6.35	6.73
С	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.043	0.94	1.09
G	0.090	BSC	2.29	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.134	0.142	3.40	3.60
R	0.180	0.215	4.57	5.46
٧	0.035	0.050	0.89	1.27
W	0.000	0.010	0.000	0.25

IPAK (STRAIGHT LEAD DPAK)

CASE 369D-01 **ISSUE B**

Z



NOTES

- 1. DIMENSIONING AND TOLERANCING PER
- ANSI Y14.5M, 1982.
 2. CONTROLLING DIMENSION: INCH

	INCHES		MILLIN	IETERS
DIM	MIN	MAX	MIN	MAX
Α	0.235	0.245	5.97	6.35
В	0.250	0.265	6.35	6.73
C	0.086	0.094	2.19	2.38
D	0.027	0.035	0.69	0.88
Е	0.018	0.023	0.46	0.58
F	0.037	0.045	0.94	1.14
G	0.090	BSC	2.29	BSC
Н	0.034	0.040	0.87	1.01
J	0.018	0.023	0.46	0.58
K	0.350	0.380	8.89	9.65
R	0.180	0.215	4.45	5.45
S	0.025	0.040	0.63	1.01
٧	0.035	0.050	0.89	1.27
Z	0.155		3.93	

STYLE 2:

PIN 1. GATE

- 2. DRAIN
- 3. SOURCE DRAIN

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